

13. TEST SETUP PHOTOGRAPHS

FCC ID: A3LSMN950F		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1705180172-13.A3L	Test Dates: 06/16/2017	DUT Type: Portable Handset	Page 49 of 51	

© 2017 PCTEST Engineering Laboratory, Inc.

REV 3.1.M
05/15/2017

© 2017 PCTEST Engineering Laboratory, Inc. All rights reserved. Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from PCTEST Engineering Laboratory, Inc. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact INFO@PCTESTLAB.COM.

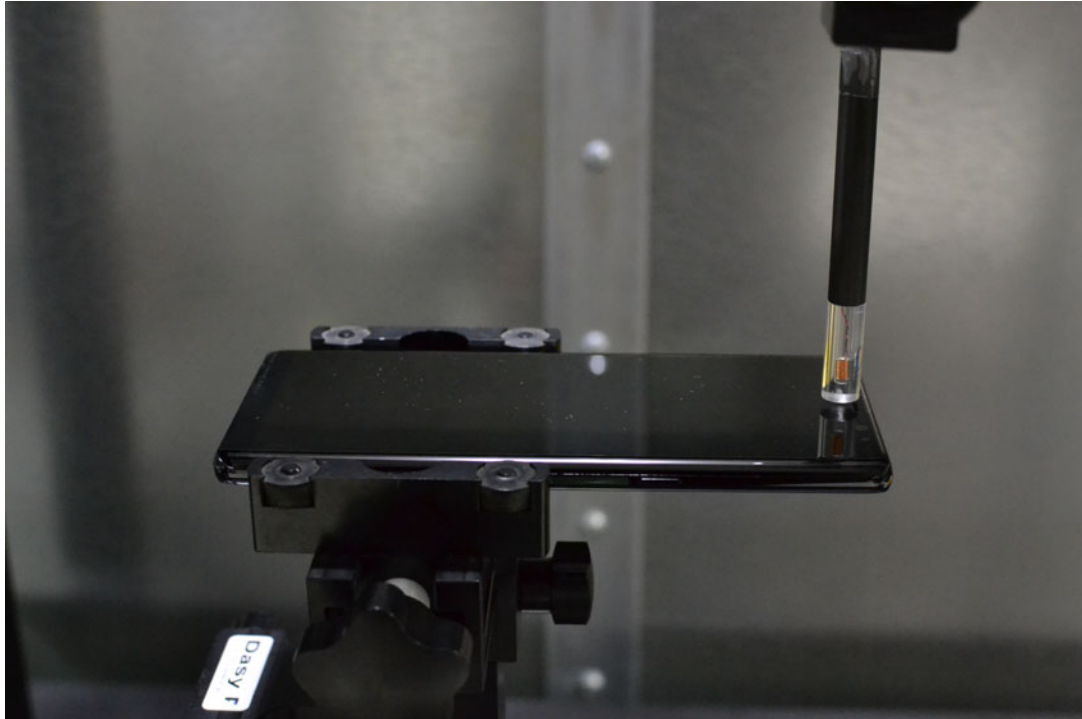


Figure 13-1
Test Setup for Wireless Device

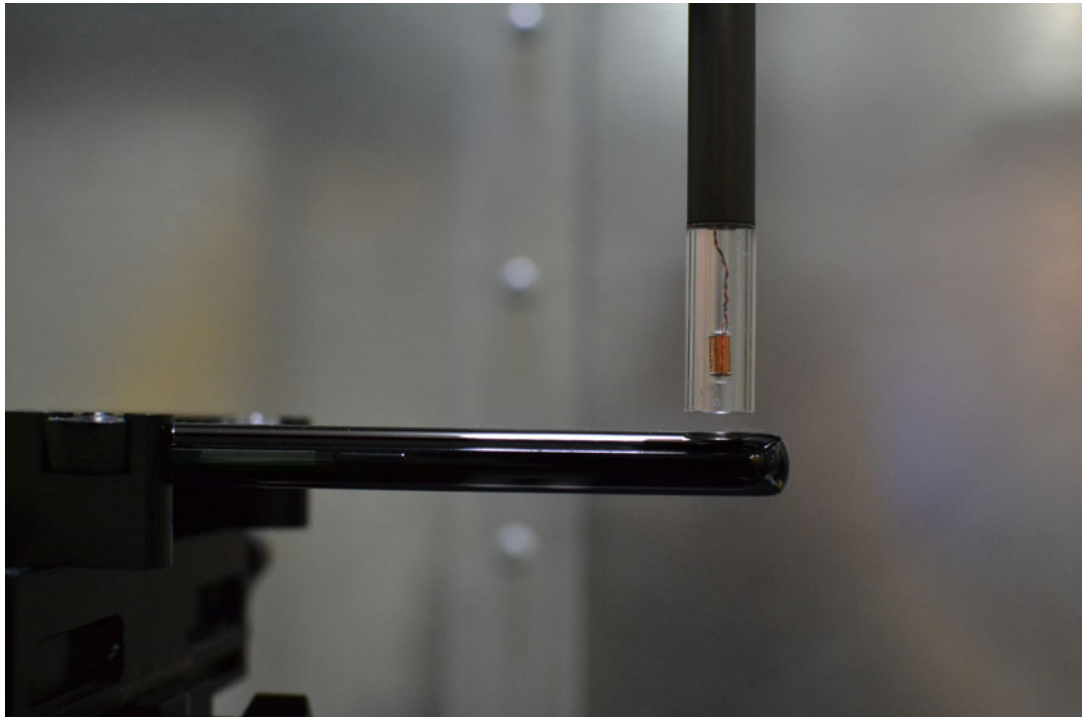


Figure 13-2
Test Setup for Wireless Device

FCC ID: A3LSMN950F		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1705180172-13.A3L	Test Dates: 06/16/2017	DUT Type: Portable Handset		Page 50 of 51

© 2017 PCTEST Engineering Laboratory, Inc.

REV 3.1.M
05/15/2017

© 2017 PCTEST Engineering Laboratory, Inc. All rights reserved. Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from PCTEST Engineering Laboratory, Inc. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact INFO@PCTESTLAB.COM.

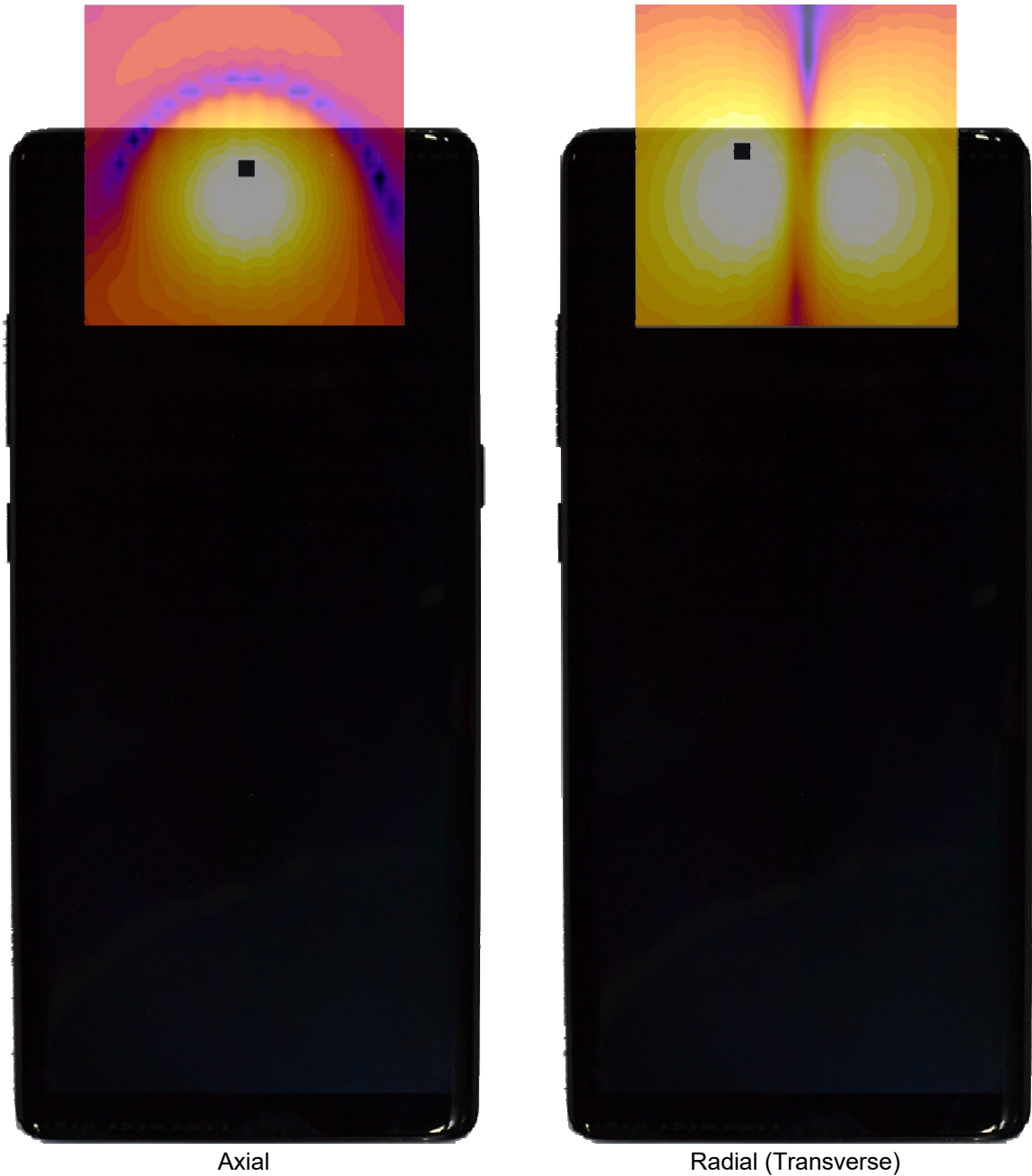


Figure 13-3
T-Coil Scan Overlay Magnetic Field Distributions

Note: Final measurement locations are indicated by a cursor on the contour plots.

FCC ID: A3LSMN950F		HAC (T-COIL) TEST REPORT		Approved by: Quality Manager
Filename: 1M1705180172-13.A3L	Test Dates: 06/16/2017	DUT Type: Portable Handset		Page 51 of 51

© 2017 PCTEST Engineering Laboratory, Inc.

REV 3.1.M
05/15/2017

© 2017 PCTEST Engineering Laboratory, Inc. All rights reserved. Unless otherwise specified, no part of this report may be reproduced or utilized in any part, form or by any means, electronic or mechanical, including photocopying and microfilm, without permission in writing from PCTEST Engineering Laboratory, Inc. If you have any questions about this international copyright or have an enquiry about obtaining additional rights to this report or assembly of contents thereof, please contact INFO@PCTESTLAB.COM.